

KWS15

RELIABILITY DATA

信頼性データ

No. RD-08T-627A		
承認	査閱	担当
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※信頼性試験は代表データであり、この値は実力値とお考え願います。

※本データに掲載しております内蔵部品の名称は、本製品を開発した当初のものです。
これらは改善等の為に変更されている可能性もありますが、ご了承下さい。

The following data are typical values and the data to be considered as ability values.
The built-in components names on this data are the things the time of Development.
Please understand that it may be changed for an improvement etc.

KWS15

M . T . B . F

1. Method of calculation

This calculation is by the 'components count method' laid down by the DC Stabilized Power Supplies (Switching mode) committee of EIAJ.

The MTBF is determined by means of a fixed component failure rate λ_G given to each component and the number of component count of each type of component. λ_G is determined based on MIL-HDBK-217D.

Please refer to the EIAJ handbook no. RCF-9021 for detail.

Formula:

$$\text{MTBF} = \frac{1}{\lambda_{\text{equip}}} = \frac{1}{\sum_{i=1}^n N_i(\lambda_G)_i} \times 10^6 \quad (\text{Hrs})$$

λ_{equip} = Total equipment failure rate (Failures/10⁶hrs)

λ_G = Failure rate of the i^{th} component

N_i = Number of i^{th} component

n = Number of categories of components

2. MTBF Value

Condition : Nominal line, rated load

Ambient Temperature 25°C

MTBF = 183,715.5 hrs.

Components Derating Data(At Nominal Line and Rated Load, Ambient Temperature 50°C)Calculation Method

A. Semiconductors

The derating factor is taken as the ratio of the actual operating junction temperature taking into consideration operating ambient temperature, power loss and thermal resistance to the maximum rated junction temperature specifications of the components.

B. IC, Resistors, Capacitors etc.

Operating ambient temperature, operating condition, power loss for each individual component are all designed to meet the requirements of Nemic-Lambda's design standard.

C. Thermal Resistance Calculation

$$\theta_{jc} = \frac{T_j(\max) - T_c}{P_c(\max)}$$

$$\theta_{ja} = \frac{T_j(\max) - T_a}{P_c(\max)}$$

Tc : Case Temperature (Normally 25°C)

Ta : Ambient Temperature (Normally 25°C)

Pc(max) : Maximum Power Loss

Tj(max) : Maximum Junction Temperature

θjc : Junction to Case Thermal Resistance

θja : Junction to ambient Thermal Resistance

認 APPD		設 ENGR		図面番号 DWG-No.	
.	.	.	.		
検 C H K		製 DWG		PA768-56-02	
.	.	.	.		

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SEMICONDUCTOR DERATING

DWG. NO. PA768-56-03

DATE : 21-MAY-1992

MODEL : KWS15-5

VIN = AC 100V

LOAD = 100%

T_a = 50 °C

Q1 2SK1663L FUJI	T _{chmax} = 150 °C	$\theta_{ch-c} = 1.563 \text{ } ^\circ\text{C/W}$	P _{d(max)} = 80.0 W
	P _d = 1.073 W	$\Delta T_c = 47.7 \text{ } ^\circ\text{C}$	T _c = 97.7 °C
	T _{ch} = T _c + (θ_{ch-c}) * P _d = 99.38 °C		
	D.F. = 66.25 %		
<hr/>			
A1 UC2842ADW UNITRODE	T _{jmax} = 150 °C	$\theta_{j-c} = 70.0 \text{ } ^\circ\text{C/W}$	P _{d(max)} = 0.725 W
	P _d = 0.31 W	$\Delta T_c = 43.1 \text{ } ^\circ\text{C}$	T _c = 93.1 °C
	T _j = T _c + (θ_{j-c}) * P _d = 114.8 °C		
	D.F. = 76.53 %		
<hr/>			
A2 HA17431FPA HITACHI	T _{jmax} = 125 °C	$\theta_{j-c} = 259.74 \text{ } ^\circ\text{C/W}$	P _{d(max)} = 0.385 W
	P _d = 0.30 mW	$\Delta T_c = 37.0 \text{ } ^\circ\text{C}$	T _c = 87.0 °C
	T _j = T _c + (θ_{j-c}) * P _d = 87.08 °C		
	D.F. = 69.66 %		
<hr/>			
PC1 (LED) TLP121GR TOSHIBA	T _{jmax} = 125 °C	$\theta_{j-c} = - - \text{ } ^\circ\text{C/W}$	P _{d(max)} = 50 mW
	I _f = 0.10 mA	$\Delta T_c = 32.9 \text{ } ^\circ\text{C}$	T _c = 82.9 °C
	Allowable I _f (max.) = 30 mA (at T _c = 82.9 °C)		
	D.F. = 0.33 %		
<hr/>			
PC1 (TRANSISTOR) TLP121GR TOSHIBA	T _{jmax} = 125 °C	$\theta_{j-c} = 400 \text{ } ^\circ\text{C/W}$	P _{d(max)} = 150 mW
	P _d = 0.37 mW	$\Delta T_c = 32.9 \text{ } ^\circ\text{C}$	T _c = 82.9 °C
	T _j = T _c + (θ_{j-c}) * P _d = 83.05 °C		
	D.F. = 66.44 %		
<hr/>			
D1 S1WB(A)60B SHINDENGEN	T _{jmax} = 150 °C	$\theta_{j-l} = 10.0 \text{ } ^\circ\text{C/W}$	P _{d(max)} = 12.5 W
	P _d = 0.634 W	$\Delta T(\text{lead}) = 44.2 \text{ } ^\circ\text{C}$	T(lead) = 94.2 °C
	T _j = T _l + (θ_{j-l}) * P _d = 100.54 °C		
	D.F. = 67.0 %		
<hr/>			
D2 1SS184TE85L TOSHIBA	T _{jmax} = 125 °C	$\theta_{j-l} = 100 \text{ } ^\circ\text{C/W}$	P _{d(max)} = 150 mW
	P _d = 42.77 mW	$\Delta T(\text{lead}) = 46.4 \text{ } ^\circ\text{C}$	T(lead) = 96.4 °C
	T _j = T _l + (θ_{j-l}) * P _d = 100.68 °C		
	D.F. = 80.54 %		
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SEMICONDUCTOR DERATING

DWG. NO.

PA768-56-04

DATE : 21-MAY-1992

MODEL : KWS15-5

VIN = AC 100V

LOAD = 100%

Ta = 50 °C

D3 D1FL20U SHINDENGEN	Tjmax = 150 °C	$\Theta_{j-l} = 23.0 \text{ } ^\circ\text{C/W}$	Pd(max) = 5.43 W
	Pd = 46.59 mW	$\Delta T(\text{lead}) = 45.8 \text{ } ^\circ\text{C}$	T(lead) = 95.8 °C
	$T_j = T_l + (\Theta_{j-l}) * P_d = 96.87 \text{ } ^\circ\text{C}$		
	D.F. = 64.58 %		
D4 EC8FS6 NIHON-INTER	Tjmax = 150 °C	$\Theta_{j-l} = 23.0 \text{ } ^\circ\text{C/W}$	Pd(max) = 5.43 W
	Pd = 52.93 mW	$\Delta T(\text{lead}) = 47.9 \text{ } ^\circ\text{C}$	T(lead) = 97.9 °C
	$T_j = T_l + (\Theta_{j-l}) * P_d = 99.12 \text{ } ^\circ\text{C}$		
	D.F. = 66.08 %		
D5 TP802C04 FUJI	Tjmax = 150 °C	$\Theta_{j-c} = 3.0 \text{ } ^\circ\text{C/W}$	Pd(max) = 41.7 W
	Pd = 1.02 W	$\Delta T_c = 58.8 \text{ } ^\circ\text{C}$	Tc = 108.8 °C
	$T_j = T_c + (\Theta_{j-c}) * P_d = 111.86 \text{ } ^\circ\text{C}$		
	D.F. = 74.57 %		
D6 TP802C04 FUJI	Tjmax = 150 °C	$\Theta_{j-c} = 3.0 \text{ } ^\circ\text{C/W}$	Pd(max) = 41.7 W
	Pd = 1.02 W	$\Delta T_c = 58.8 \text{ } ^\circ\text{C}$	Tc = 108.8 °C
	$T_j = T_c + (\Theta_{j-c}) * P_d = 111.86 \text{ } ^\circ\text{C}$		
	D.F. = 74.57 %		
D7 1SS184TE85L TOSHIBA	Tjmax = 125 °C	$\Theta_{j-l} = 100 \text{ } ^\circ\text{C/W}$	Pd(max) = 150 mW
	Pd = 0 mW	$\Delta T(\text{lead}) = 40.0 \text{ } ^\circ\text{C}$	T(lead) = 90.0 °C
	$T_j = T_l + (\Theta_{j-l}) * P_d = 90.0 \text{ } ^\circ\text{C}$		
	D.F. = 72.0 %		
ZD1 1N4735A MOTOROLA	Tjmax = 200 °C	$\Theta_{j-c} = 175 \text{ } ^\circ\text{C/W}$	Pd(max) = 1.0 W
	Pd = 0 W	$\Delta T_c = 43.5 \text{ } ^\circ\text{C}$	Tc = 93.5 °C
	$T_j = T_c + (\Theta_{j-c}) * P_d = 93.5 \text{ } ^\circ\text{C}$		
	D.F. = 46.6 %		
Q2 2SC2873-Y TOSHIBA	Tjmax = 150 °C	$\Theta_{j-c} = 125 \text{ } ^\circ\text{C/W}$	Pd(max) = 1.0 W
	Pd = 0 W	$\Delta T_c = 30.0 \text{ } ^\circ\text{C}$	Tc = 80.0 °C
	$T_j = T_c + (\Theta_{j-c}) * P_d = 80.0 \text{ } ^\circ\text{C}$		
	D.F. = 53.3 %		

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dT TEMPERATURE RISE

DWG. NO. PA768-66-02

MODEL : KWS15-5

DATE : 15-MAY-1992

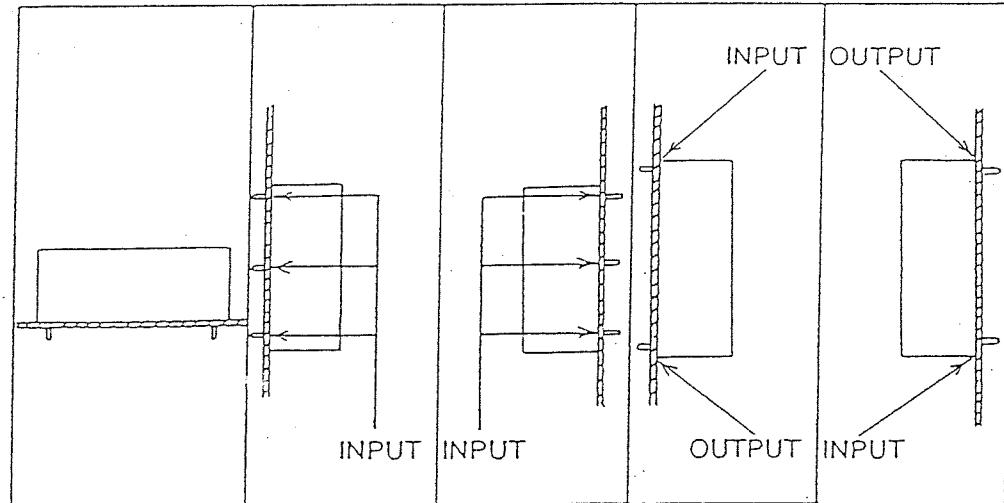
INPUT VOLTAGE = 100VAC

Ta = 50 °C		dT TEMPERATURE RISE (°C)				
OUTPUT DERATING (%)		100%	100%	100%	100%	100%
SYMBOL	PARTS NAME	MOUNTING A	MOUNTING B	MOUNTING C	MOUNTING D	MOUNTING E
Q1	MOSFET	47.7	47.4	45.3	44.2	45.4
A1	PWM IC	43.1	43.3	40.2	39.5	40.2
D5	SBD	58.8	58.2	58.4	58.6	58.6
T1	X'TIMER	53.0	52.3	52.0	49.4	51.8
C5	E.CAP	36.3	37.0	33.8	32.8	34.5
C16	OS CAP.	36.5	37.1	33.7	31.7	37.0

INPUT VOLTAGE = 200VAC

Ta = 50 °C		dT TEMPERATURE RISE (°C)				
OUTPUT DERATING (%)		100%	100%	100%	100%	100%
SYMBOL	PARTS NAME	MOUNTING A	MOUNTING B	MOUNTING C	MOUNTING D	MOUNTING E
Q1	MOSFET	53.8	53.3	49.6	49.9	49.8
A1	PWM IC	45.7	45.7	41.3	41.8	41.4
D5	SBD	60.6	60.8	60.1	60.0	60.2
T1	X'TIMER	55.4	54.5	52.9	51.5	52.6
C5	E.CAP	39.7	40.2	35.4	35.8	36.2
C16	OS CAP.	38.6	39.0	34.4	33.4	37.8

MOUNTING MOUNTING MOUNTING MOUNTING MOUNTING
 A B C D E



ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

MODEL : KWS15-5

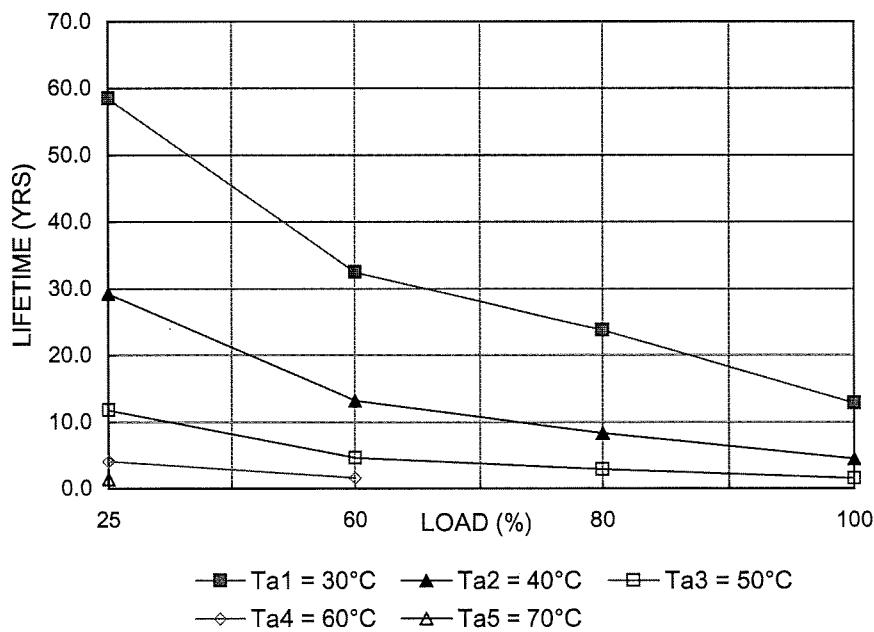
MOUNTING : A

VIN : 100VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
25	58.5	29.3	11.8	4.1	1.5
60	32.5	13.2	4.7	1.6	
80	23.8	8.4	2.9		
100	12.8	4.5	1.6		

GRAPH OF ELECTROLYTIC CAPACITOR LIFETIME VS LOAD
MOUNTING A KWS15-5



計算式 FORMULA

- | | |
|--|--|
| 1. アルミ電解コンデンサ
AL. Electrolytic capacitor
$L = Lo \times 2^{(105-Tc)/10}$ | L : 電解コンデンサ推定寿命計算値
Elec. Capacitor computed life.
(24時間連続稼動、365日)
(24 hrs per day, 365 days per year) |
| 2. OSコンデンサ
O.S capacitor
$L = Lo \times 10^{(105-Tc)/20}$ | Lo : 電解コンデンサ保証寿命値
Guarantee life for Elec. cap.
Tc : 電解コンデンサのケース温度
Case temperature of Elec. cap. |

ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

MODEL : KWS15-5

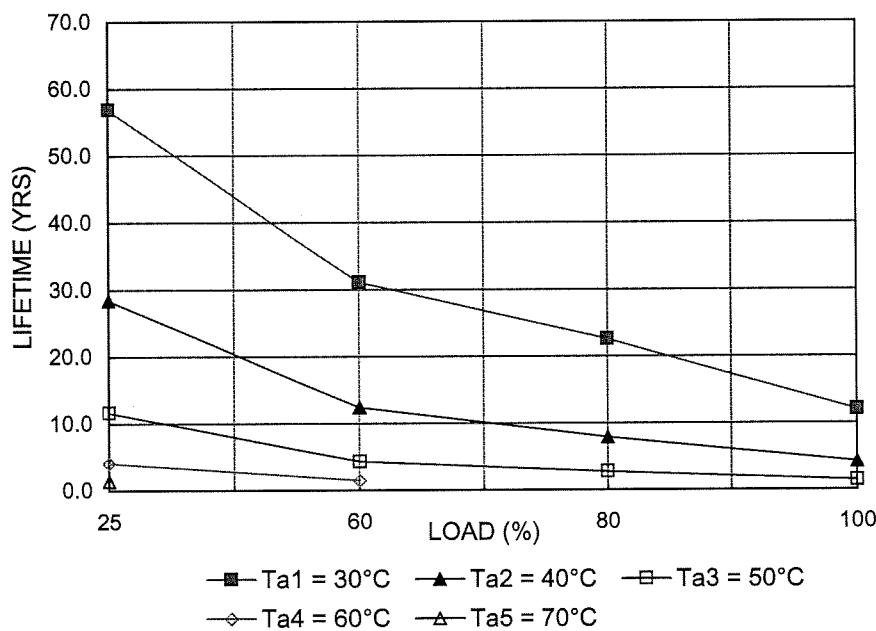
MOUNTING : B

VIN : 100VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
25	56.9	28.5	11.7	4.1	1.4
60	31.1	12.4	4.4	1.5	
80	22.6	7.9	2.8		
100	12.1	4.2	1.5		

GRAPH OF ELECTROLYTIC CAPACITOR LIFETIME VS LOAD
MOUNTING B KWS15-5



計算式 FORMULA

1. アルミ電解コンデンサ

AL. Electrolytic capacitor

$$L = Lo \times 2^{(105-T_c)/10} \quad (\text{year})$$

L : 電解コンデンサ推定寿命計算値

Elec. Capacitor computed life.

(24時間連続稼動、365日)

(24 hrs per day, 365 days per year)

2. OSコンデンサ

O.S capacitor

$$L = Lo \times 10^{(105-T_c)/20} \quad (\text{year})$$

Lo : 電解コンデンサ保証寿命値

Guarantee life for Elec. cap.

Tc : 電解コンデンサのケース温度

Case temperature of Elec. cap.

ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

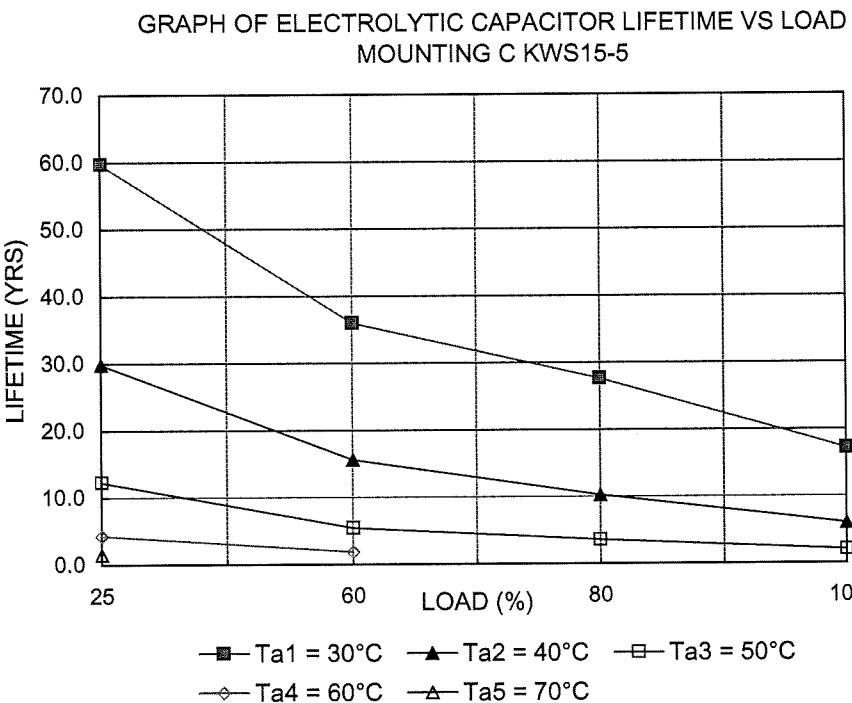
MODEL : KWS15-5

MOUNTING : C

VIN : 100VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
25	59.8	29.9	12.3	4.3	1.5
60	36.0	15.7	5.5	1.9	
80	27.7	10.3	3.6		
100	17.2	6.0	2.1		



計算式 FORMULA

- | | | |
|--|--------|--|
| 1. アルミ電解コンデンサ
AL. Electrolytic capacitor
$L = Lo \times 2^{(105-Tc)/10}$ | L : | 電解コンデンサ推定寿命計算値
Elec. Capacitor computed life.
(24時間連続稼動、365日)
(24 hrs per day, 365 days per year) |
| 2. OSコンデンサ
O.S capacitor
$L = Lo \times 10^{(105-Tc)/20}$ | Lo : | 電解コンデンサ保証寿命値
Guarantee life for Elec. cap. |
| | Tc : | 電解コンデンサのケース温度
Case temperature of Elec. cap. |

ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

MODEL : KWS15-5

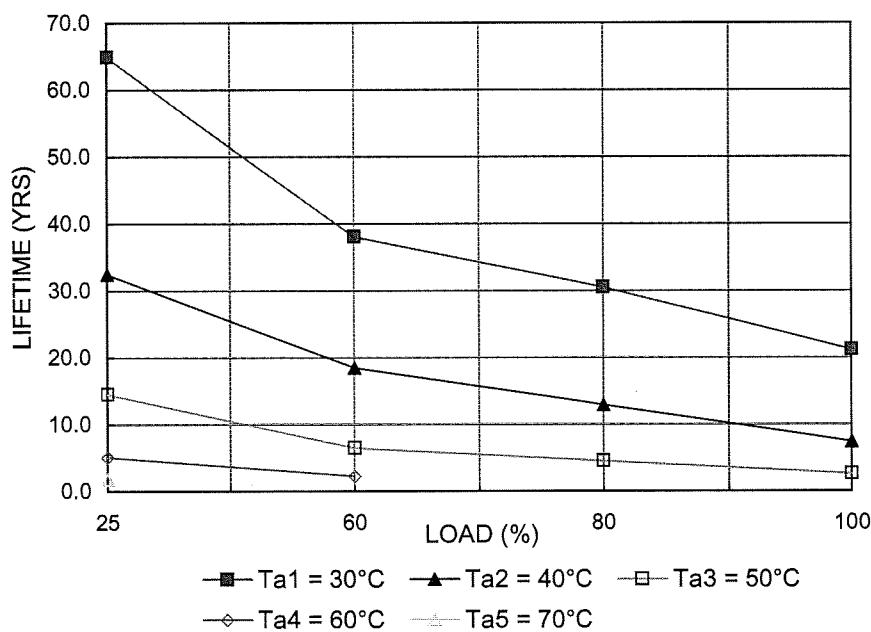
MOUNTING : D

VIN : 100VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
25	64.9	32.5	14.6	5.1	1.8
60	38.1	18.5	6.5	2.3	
80	30.5	13.0	4.6		
100	21.2	7.5	2.6		

GRAPH OF ELECTROLYTIC CAPACITOR LIFETIME VS LOAD
MOUNTING D KWS15-5



計算式 FORMULA

1. アルミ電解コンデンサ
AL. Electrolytic capacitor
 $L = Lo \times 2^{(105-Tc)/10}$ (year)

L : 電解コンデンサ推定寿命計算値
Elec. Capacitor computed life.
(24時間連続稼動、365日)
(24 hrs per day, 365 days per year)

2. OSコンデンサ
O.S capacitor
 $L = Lo \times 10^{(105-Tc)/20}$ (year)

Lo : 電解コンデンサ保証寿命値
Guarantee life for Elec. cap.
Tc : 電解コンデンサのケース温度
Case temperature of Elec. cap.

ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

MODEL : KWS15-5

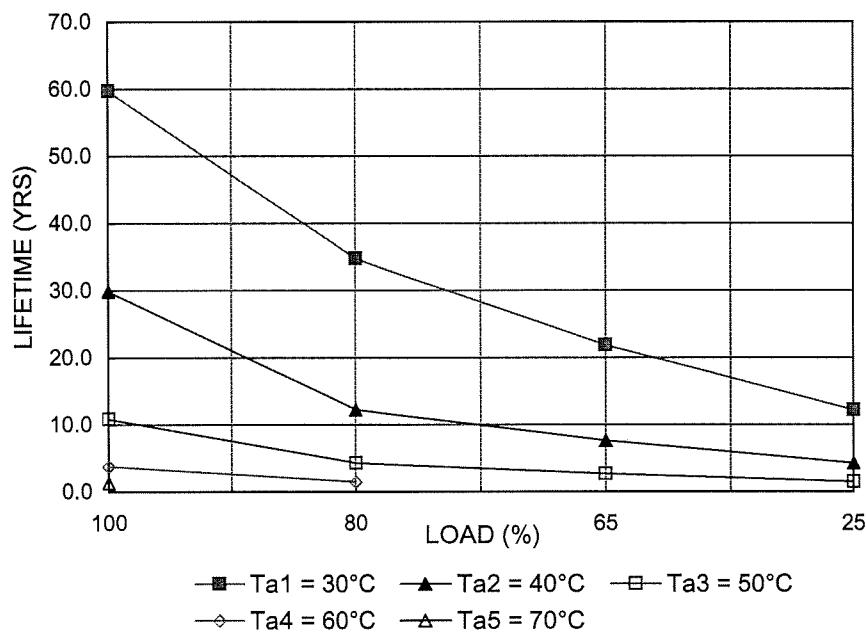
MOUNTING : E

VIN : 100VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
100	59.8	29.9	10.9	3.8	1.3
80	34.8	12.3	4.3	1.5	
65	21.9	7.7	2.7		
25	12.2	4.3	1.5		

GRAPH OF ELECTROLYTIC CAPACITOR LIFETIME VS LOAD
MOUNTING E KWS15-5



計算式 FORMULA

- | | |
|--|--|
| 1. アルミ電解コンデンサ
AL. Electrolytic capacitor
$L = Lo \times 2^{(105-Tc)/10}$ | L : 電解コンデンサ推定寿命計算値
Elec. Capacitor computed life.
(24時間連続稼動、365日)
(24 hrs per day, 365 days per year) |
| 2. OSコンデンサ
O.S capacitor
$L = Lo \times 10^{(105-Tc)/20}$ | Lo : 電解コンデンサ保証寿命値
Guarantee life for Elec. cap.
Tc : 電解コンデンサのケース温度
Case temperature of Elec. cap. |

ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

MODEL : KWS15-5

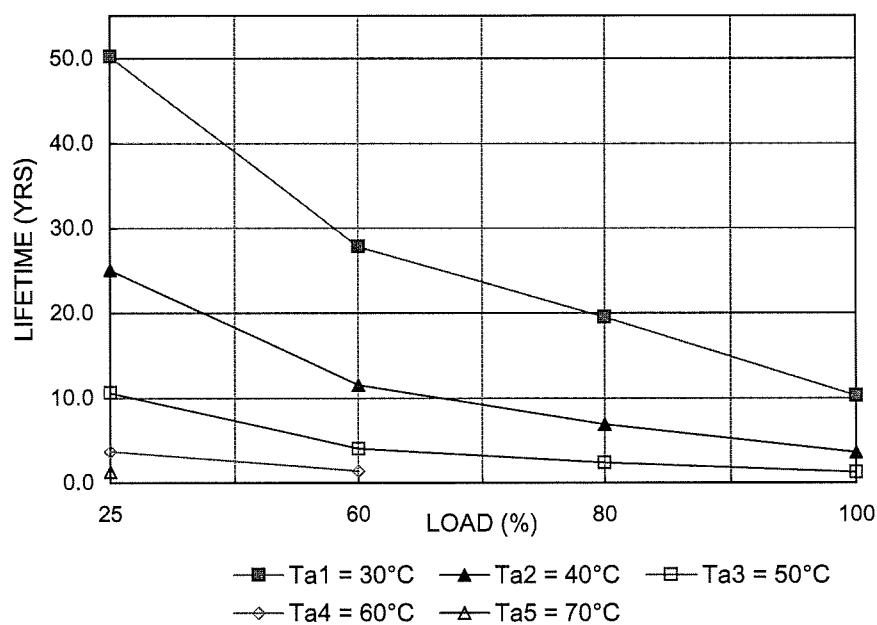
MOUNTING : A

VIN : 200VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
25	50.2	25.1	10.6	3.73389631	1.31104259
60	27.9	11.6	4.1	1.42554337	
80	19.6	6.9	2.4		
100	10.3	3.6	1.3		

GRAPH OF ELECTROLYTIC CAPACITOR LIFETIME VS LOAD
MOUNTING A KWS15-5



計算式 FORMULA

1. アルミ電解コンデンサ
AL. Electrolytic capacitor

L : 電解コンデンサ推定寿命計算値

Elec. Capacitor computed life.

(24時間連続稼動、365日)

(24 hrs per day, 365 days per year)

$$L = Lo \times 2^{\frac{105-Tc}{10}} \quad (year)$$

Lo : 電解コンデンサ保証寿命値

Guarantee life for Elec. cap.

2. OSコンデンサ
O.S capacitor

Tc : 電解コンデンサのケース温度

Case temperature of Elec. cap.

$$L = Lo \times 10^{\frac{105-Tc}{22}} \quad (year)$$

ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

MODEL : KWS15-5

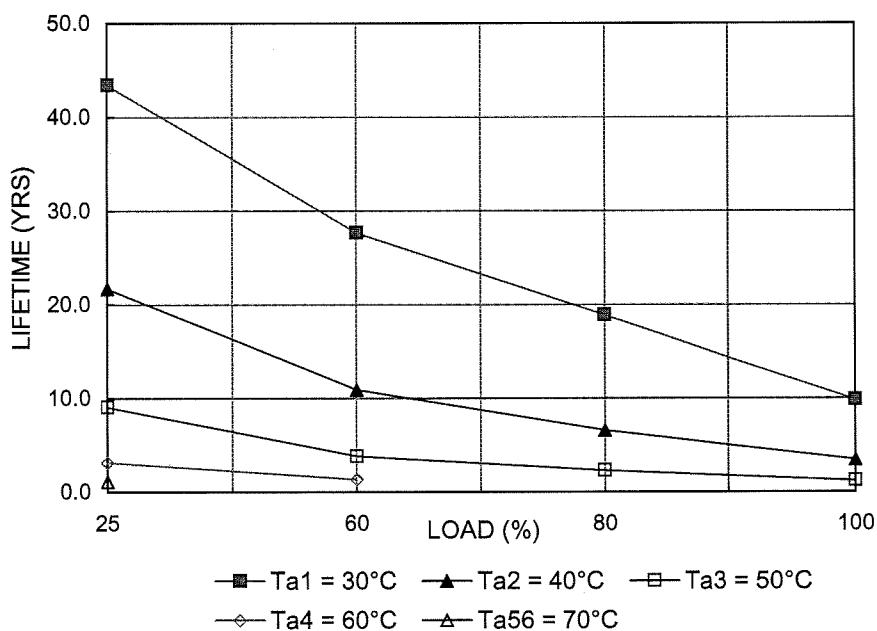
MOUNTING : B

VIN : 200VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
25	43.4	21.7	9.1	3.2	1.1
60	27.7	11.0	3.9	1.4	
80	18.9	6.6	2.3		
100	9.9	3.5	1.2		

GRAPH OF ELECTROLYTIC CAPACITOR LIFETIME VS LOAD
MOUNTING B KWS15-5



計算式 FORMULA

1. アルミ電解コンデンサ

AL. Electrolytic capacitor

$$L = Lo \times 2^{(105-T_c)/10} \quad (\text{year})$$

L : 電解コンデンサ推定寿命計算値

Elec. Capacitor computed life.

(24時間連続稼動、365日)

(24 hrs per day, 365 days per year)

2. OSコンデンサ

O.S capacitor

$$L = Lo \times 10^{(105-T_c)/20} \quad (\text{year})$$

Lo : 電解コンデンサ保証寿命値

Guarantee life for Elec. cap.

Tc : 電解コンデンサのケース温度

Case temperature of Elec. cap.

ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

MODEL : KWS15-5

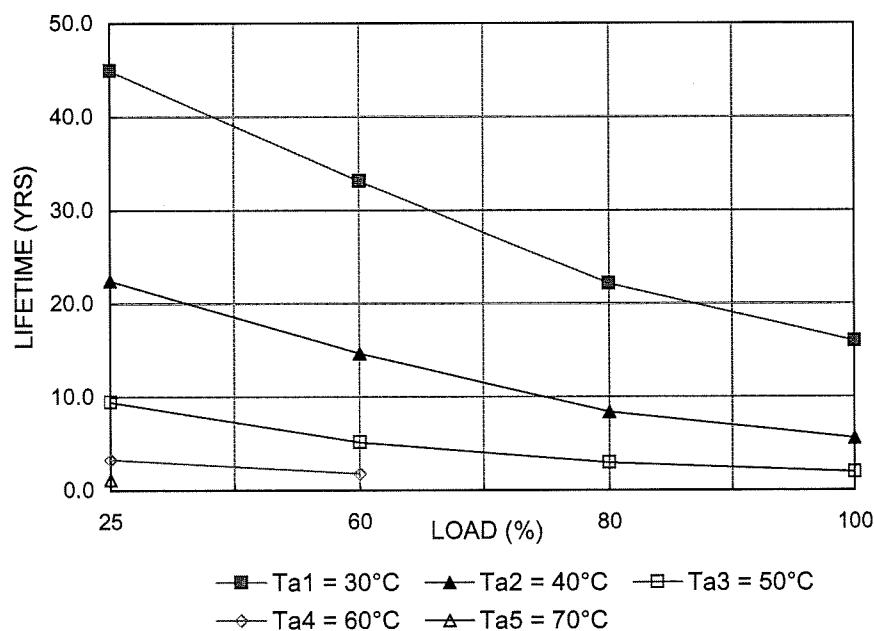
MOUNTING : C

VIN : 200VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
25	45.0	22.5	9.5	3.3	1.2
60	33.2	14.7	5.2	1.8	
80	22.2	8.4	3.0		
100	16.0	5.6	2.0		

GRAPH OF ELECTROLYTIC CAPACITOR LIFETIME VS LOAD
MOUNTING C KWS15-5



計算式 FORMULA

- | | | |
|--|--------|--|
| 1. アルミ電解コンデンサ
AL. Electrolytic capacitor
$L = Lo \times 2^{(105-Tc)/10}$ | L : | 電解コンデンサ推定寿命計算値
Elec. Capacitor computed life.
(24時間連続稼動、365日)
(24 hrs per day, 365 days per year) |
| 2. OSコンデンサ
O.S capacitor
$L = Lo \times 10^{(105-Tc)/20}$ | Lo : | 電解コンデンサ保証寿命値
Guarantee life for Elec. cap. |
| | Tc : | 電解コンデンサのケース温度
Case temperature of Elec. cap. |

ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

MODEL : KWS15-5

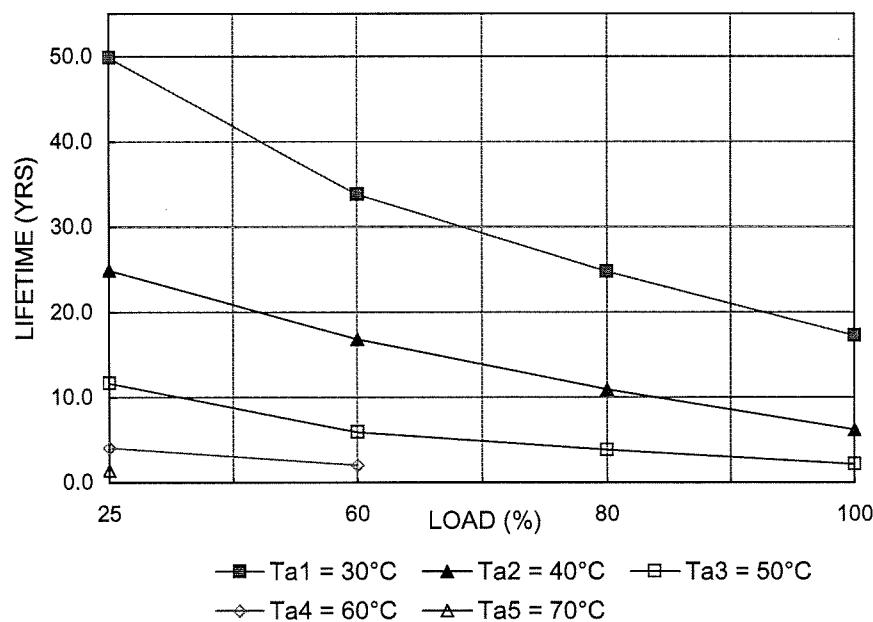
MOUNTING : D

VIN : 200VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
25	49.9	25.0	11.7	4.1	1.4
60	33.8	16.9	5.9	2.1	
80	24.8	11.0	3.9		
100	17.3	6.2	2.2		

GRAPH OF ELECTROLYTIC CAPACITOR LIFETIME VS LOAD
MOUNTING D KWS15-5



計算式 FORMULA

1. アルミ電解コンデンサ
AL. Electrolytic capacitor
 $L = Lo \times 2^{(105-Tc)/10}$

L : 電解コンデンサ推定寿命計算値
Elec. Capacitor computed life.
(24時間連続稼動、365日)
(24 hrs per day, 365 days per year)

2. OSコンデンサ
O.S capacitor
 $L = Lo \times 10^{(105-Tc)/20}$

Lo : 電解コンデンサ保証寿命値
Guarantee life for Elec. cap.
Tc : 電解コンデンサのケース温度
Case temperature of Elec. cap.

ELECTROLYTIC CAPACITOR LIFETIME VERSUS LOAD

MODEL : KWS15-5

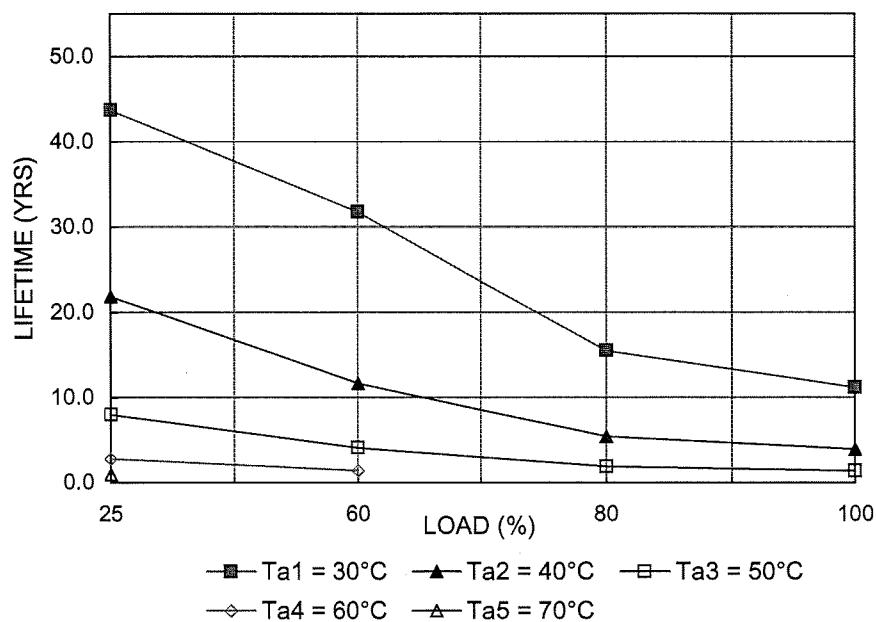
MOUNTING : E

VIN : 200VAC

DATE: SEPT 12, 2008

LOAD (%)	LIFETIME (YRS)				
	Ta = 30°C	Ta = 40°C	Ta = 50°C	Ta = 60°C	Ta = 70°C
25	43.7	21.9	8.0	2.8	1.0
60	31.8	11.7	4.1	1.4	
80	15.5	5.4	1.9		
100	11.2	3.9	1.4		

GRAPH OF ELECTROLYTIC CAPACITOR LIFETIME VS LOAD
MOUNTING E KWS15-5



計算式 FORMULA

- | | |
|--|--|
| 1. アルミ電解コンデンサ
AL. Electrolytic capacitor
$L = Lo \times 2^{(105-Tc)/10}$ | L : 電解コンデンサ推定寿命計算値
Elec. Capacitor computed life.
(24時間連続稼動、365日)
(24 hrs per day, 365 days per year) |
| 2. OSコンデンサ
O.S capacitor
$L = Lo \times 10^{(105-Tc)/20}$ | Lo : 電解コンデンサ保証寿命値
Guarantee life for Elec. cap.
Tc : 電解コンデンサのケース温度
Case temperature of Elec. cap. |

MODEL : KWS15-5		ABNORMAL TESTING		TEST CONDITIONS		TEST	
				LOAD = 100 % Vin = 100VAC		LOAD = 100 % Vin = 100VAC	
				Ta = 25°C		Ta = 25°C	
PARTS	NAME	TEST MODE					
		P A R T	S O P H O R T	F I R O K E	B M E R S L	U D A C V P N	R E T S T D
1	UR1717H-702Y0R3-01	L1	*	(a)(b)	T	N	*
2	UR1717H-702Y0R3-01	L1	*				*
3							*
4	S1WB(A)60B	D1	AC	*		*	*
5	S1WB(A)60B	D1	AC	*		*	*
6	S1WB(A)60B	D1	DC	*		*	*
7	S1WB(A)60B	D1	DC	*		*	*
8							
9	ISS184TE85L	D2	A-K	*		*	*
10	ISS184TE85L	D2	A-K	*		*	*
11							
12	D1FL20U	D3	A-K	*		*	*
13	D1FL20U	D3	A-K	*		*	*
14							
15	EC8FS6	D4	A-K	*		*	*
16	EC8FS6	D4	A-K	*		*	*
17							
18	TP802C04	D5	A-K	*		*	*
19	TP802C04	D5	A-K	*		*	*
20							
21	TP802C04	D6	A-K	*		*	*
22	TP802C04	D6	A-K	*		*	*
23							
24							

*** a : slight b : prolonged

TDK-Lambda

PARTS NAME	TEST MODE	ABNORMAL TESTING		TEST CONDITIONS		NOTE
		LOAD = 100 %	Vin = 100VAC	Ta = 25°C.	R E	
P A R T N O.		S H O R T	F I R O E K E	F U S R D E	N O C . V P .	O T E S T
1 ISS184TE85L	D7	A-K *	(a)(b)	U M E D M A L G O P .	N O C . V P .	T E S T
2 ISS184TE85L	D7	A-K *		W R E S L T L H O E W .	N O C . V P .	T E S T
3				T L O E N .	T E	*
4 1N4735A	ZD1	A-K *				*
5 1N4735A	ZD1	A-K *				*
6						*
7 TLP121GR (DIODE)	PC1	1-3 *				*
8 TLP121GR (DIODE)	PC1	1-3 *				*
9 TLP121GR (TRANS)	PC1	4-6 *				*
10 TLP121GR (TRANS)	PC1	4-6 *				*
11						*
12 HA17431FPA-TR	A2	A-K *				*
13 HA17431FPA-TR	A2	REF-A *				*
14						*
15 2SK1663L	Q1	D-S *				*
16 2SK1663L	Q1	G-S *				*
17						*
18 2SC2873-Y	Q2	B-E *				*
19 2SC2873-Y	Q2	C-E *				*
20 2SC2873-Y	Q2	B-C *				*
21						*
22						*
23						*
24						*

*** a : slight b : prolonged

TDK-Lambda

MODEL : KWS15-5		ABNORMAL TESTING		TEST CONDITIONS		TEST BY	
				LOAD = 100 % Vin = 100VAC		APPROVED BY TESTED BY	
				Ta = 25°C			
TEST MODE							
P A R T	N 0.	S H O R T	F I R E	B U R S L	R E D A L	U D C V P N T E	N O O C U T A E R S T E
PARTS NAME							
(a) (b)							
1 MKC-S683M	C1	*				*	*
2 MKC-S683M	C1	*				*	*
3						*	
4 MKC-S683M	C2	*				*	*
5 MKC-S683M	C2	*				*	*
6							
7 PME290MA4330M	C3	*				*	*
8 PME290MA4330M	C3	*				*	*
9							
10 PME290MA4330M	C4	*				*	*
11 PME290MA4330M	C4	*				*	*
12							
13 LXA400VBSN-75(M)	C5	*				*	*
14 LXA400VBSN-75(M)	C5	*				*	*
15							
16 C55Y5U1E186Z-TE12	C6	*				*	*
17 C55Y5U1E186Z-TE12	C6	*				*	*
18							
19 C2012X7R1E104KT	C7	*				*	*
20 C2012X7R1E104KT	C7	*				*	*
21							
22 C3225COG1H332J	C8	*				*	*
23 C3225COG1H332J	C8	*				*	*
24							

*** a : slight b : prolonged

TDK-Lambda

MODEL : KWS15-5		ABNORMAL TESTING		TEST MODE		TEST CONDITIONS		LOAD = 100 %		TEST CONDITIONS		LOAD = 100 %		TEST CONDITIONS	
								Vin = 100VAC	Ta = 25°C			Vin = 100VAC	Ta = 25°C		
		P A R T N 0.	S H O R E T	F I R O E	S M R S L	F D E D M	R E A D M	U R B S L	N O C V P	R E K T A	N O C H P	R E K T A	N O C H P	R E K T A	N O C H P
1	C2012COG1H101KT	C9	*												
2	C2012COG1H101KT	C9	*												*
3															*
4	C2012COG1H221KT	C10	*												*
5	C2012COG1H221KT	C10	*												*
6															*
7	GR43-2W5R103K500PT	C11	*												*
8	GR43-2W5R103K500PT	C11	*												*
9															*
10	C2012X7R1H473KT	C12	*												*
11	C2012X7R1H473KT	C12	*												*
12															*
13	C25Y5U1E106Z	C13	*												*
14	C25Y5U1E106Z	C13	*												*
15															*
16	C25Y5U1E106Z	C14	*												*
17	C25Y5U1E106Z	C14	*												*
18															*
19	C25Y5U1E106Z	C15	*												*
20	C25Y5U1E106Z	C15	*												*
21															*
22	10SA68M+H	C16	*												*
23	10SA68M+H	C16	*												*
24															*

*** a : slight b : prolonged

TDK-Lambda

MODEL : KWS15-5		TEST MODE		ABNORMAL		TESTING		TEST CONDITIONS		LOAD = 100 %		Vin = 100VAC		TESTED BY		
		P	A	S	H	B	M	R	E	D	F	U	N	O	R	N
		R	T	O	P	W	E	D	A	M	S	O	C	E	G	
		T	N.	R	T	K	E	R	E	A	L	V	T	E	O	
1	C2012X7R1E104KT	C17	*													
2	C2012X7R1E104KT	C17	*													
3																
4	DE7100FZ472PVA1-KC	C18	*													
5	DE7100FZ472PVA1-KC	C18	*													
6																
7	CM21W5R102K200BT	C20	*													
8	CM21W5R102K200BT	C20	*													
9																
10	C3216X7R1E334KT	C21	*													
11	C3216X7R1E334KT	C21	*													
12																
13	10SA68M+H	C22	*													
14	10SA68M+H	C22	*													
15																
16	ERJ8GEYJ304V	R1	*													
17	ERJ8GEYJ304V	R1	*													
18																
19	ERJ8GEYJ304V	R2	*													
20	ERJ8GEYJ304V	R2	*													
21																
22	ERJ8GEYJ304V	R3	*													
23	ERJ8GEYJ304V	R3	*													
24																

*** a : slight b : prolonged

TDK-Lambda

MODEL : KWS15-5		ABNORMAL TESTING		TEST MODE		TEST CONDITIONS		TESTED BY	
						LOAD = 100 %		APPROVED BY	
						Vin = 100VAC		TESTED BY	
						Ta = 25°C			
P	A	S	H	F	S	R	D	N	R
A	R	H	P	M	U	E	E	O	E
T	T	O	E	I	R	D	A	T	T
N	N	R	N	O	S	L	M	E	E
0.	0.	T	T	K	T	L	A	S	S
				E	E	G	G	O	G
				(a)	(b)	W	W	P	N
						N	N	T	T
						E	E	E	D
1	ERG1SJ623	R4	*						*
2	ERG1SJ623	R4	*						*
3									
4	ERG1SJ623	R5	*						*
5	ERG1SJ623	R5	*						*
6									
7	CR1/10W2001DV	R6	*						*
8	CR1/10W2001DV	R6	*						*
9									
10	CR1/10W152JV	R7	*						*
11	CR1/10W152JV	R7	*						*
12									
13	ERJ8GEYJ100V	R8	*						*
14	ERJ8GEYJ100V	R8	*						*
15									
16	ERJ8GEYJ390V	R9	*						*
17	ERJ8GEYJ390V	R9	*						*
18									
19	CR1/10W102JV	R10	*						*
20	CR1/10W102JV	R10	*						*
21									
22	CR1/10W331JV	R11	*						*
23	CR1/10W331JV	R11	*						*
24									

***a : slight b : prolonged

TDK-Lambda

MODEL : KWS15-5		ABNORMAL TESTING		TEST MODE		TEST CONDITIONS		LOAD = 100 %		TESTED BY	
								Vin = 100VAC			
								Ta = 25°C			
PARTS	NAME	S	O	F	S	R	D	U	N	R	N
A	T	H	P	I	M	E	A	E	O	E	O
R	N	O	R	R	O	R	D	B	T	E	G
T	0.	E	T	K	S	L	M	A	A	S	C
1	CR1/10W183JV	R12	*						*		*
2	CR1/10W183JV	R12	*						*		*
3											
4	ERJ8GEYJ3R9V	R13	*						*		*
5	ERJ8GEYJ3R9V	R13	*						*		*
6											
7	ERJ8GEYJ3R9V	R14	*						*		*
8	ERJ8GEYJ3R9V	R14	*						*		*
9											
10	ERJ8GEYJ3R9V	R15	*						*		*
11	ERJ8GEYJ3R9V	R15	*						*		*
12											
13	ERJ8GEYJ620V	R16	*						*		*
14	ERJ8GEYJ620V	R16	*						*		*
15											
16	ERJ8GEYJ620V	R17	*						*		*
17	ERJ8GEYJ620V	R17	*						*		*
18											
19	ERJ8GEYJ620V	R18	*						*		*
20	ERJ8GEYJ620V	R18	*						*		*
21											
22	ERJ8GEYJ823V	R19	*						*		*
23	ERJ8GEYJ823V	R19	*						*		*
24											

*** a : slight b : prolonged

TDK-Lambda

MODEL : KWS15-5		ABNORMAL TESTING		TEST MODE		TEST CONDITIONS		LOAD = 100 %		TESTED BY	
								Vin = 100VAC		APPROVED BY	
								Ta = 25°C			
PARTS	NAME	P A R T N O.	S H O R T .	F I R E	S M O K E	B U R E T	R D M A L H G O E N	F U S E D A M B C V P P N .	N O O C T U H A P P N R U G T E	R E O K T N S T T D	
1	ERJ8GEYJ823V	R20	*								*
2	ERJ8GEYJ823V	R20	*								*
3											
4	ERJ8GEYJ823V	R21	*								*
5	ERJ8GEYJ823V	R21	*								*
6											
7	ERJ8GEYJ823V	R22	*								*
8	ERJ8GEYJ823V	R22	*								*
9											
10	ERJ8GEYJ100V	R23	*								*
11	ERJ8GEYJ100V	R23	*								*
12											
13	ERJ8GEYJ100V	R24	*								*
14	ERJ8GEYJ100V	R24	*								*
15											
16	ERJ8GEYJ100V	R25	*								*
17	ERJ8GEYJ100V	R25	*								*
18											
19	ERJ8GEYJ100V	R26	*								*
20	ERJ8GEYJ100V	R26	*								*
21											
22	ERJ8GEYJ241V	R27	*								*
23	ERJ8GEYJ241V	R27	*								*
24											

* : slight b : prolonged

TDK-Lambda

MODEL :	KWS15-5	ABNORMAL TESTING		TEST MODE		TEST CONDITIONS		LOAD = 100 %	Vin = 100VAC	Ta = 25°C	APPROVED BY	TESTED BY
		TEST	MODE	TEST	MODE	TEST	MODE					
1	ERJ8GEYJ241V	R28	*	S	O	F	S	U	D	S	R	N
2	ERJ8GEYJ241V	R28	*	H	P	I	M	E	A	E	E	O
3				O	E	R	R	E	D	M	T	C
4	ERJ8GEYJ241V	R29	*	R	N	K	L	R	M	A	S	G
5	ERJ8GEYJ241V	R29	*	T	T	E	T	T	A	E	T	O
6				(a)	(b)							D
7	CRI/10W2001DV	R30	*									*
8	CRI/10W2001DV	R30	*									*
9												
10	CRI/10W2051DV	R31	*									*
11	CRI/10W2051DV	R31	*									*
12												
13	CRI/10W152JV	R32	*									*
14	CRI/10W152JV	R32	*									*
15												
16	CRI/10W222JV	R33	*									*
17	CRI/10W222JV	R33	*									*
18												
19	ERJ8GEYJ301V	R34	*									*
20	ERJ8GEYJ301V	R34	*									*
21												
22	ERJ8GEYJ101V	R35	*									*
23	ERJ8GEYJ101V	R35	*									*
24												

*** a : slight b : prolonged

TDK-Lambda

MODEL : KWS15-5		ABNORMAL TESTING		TEST MODE		TEST CONDITIONS		LOAD = 100 %		TESTED BY	
								Vin = 100VAC		APPROVED BY	
						Ta = 25°C				TESTED BY	
PARTS	NAME	P	A	S	O	B	M	F	R	D	N
		A	R	H	P	E	R	I	E	E	O
		T	T	O	R	N	L	M	A	V	E
		N.	N.	T	T	E	T	D	M	P	G
								(a) (b)			
1	ERJ8GEYJ563V	R36	*								*
2	ERJ8GEYJ563V	R36	*								*
3											
4	ERJ8GEYJ332V	R37	*								*
5	ERJ8GEYJ332V	R37	*								*
6											
7	ERJ8GEYJ100V	R38	*								*
8	ERJ8GEYJ100V	R38	*								*
9											
10	ERJ8GEYJ241V	R39	*								*
11	ERJ8GEYJ241V	R39	*								*
12											
13											
14											
15											
16											
17											
18											
19											
20											
21											
22											
23											
24											

*** a : slight b : prolonged

TDK-Lambda

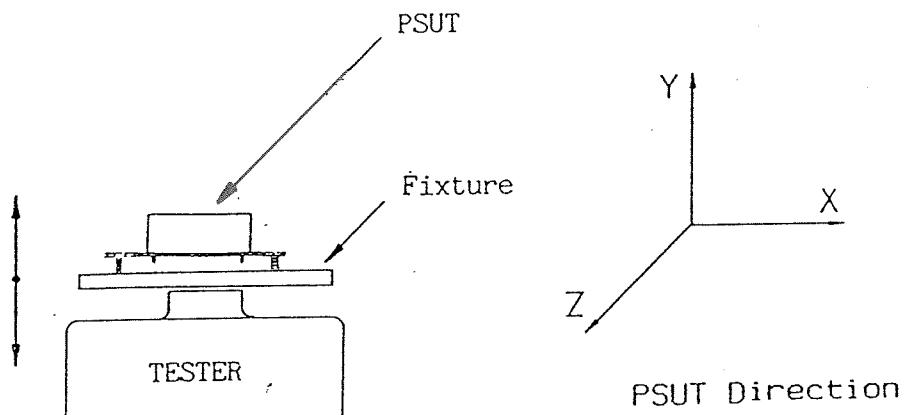
VIBRATION TEST

TYPES OF VIBRATION TEST :

- A) OSCILLATOR FREQUENCY SWEEP
B) RESONANCE FREQUENCY

EQUIPMENT : EMIC CORPORATION VIBRATION TEST SYSTEM F-400-BM-E47
VIBRATION GENERATOR 905-FN

PROCEDURE :



VIBRATION TEST WITH FREQUENCY SWEEP

FREQUENCY	10 ~ 55 Hz.
SWEEP TIME	1 min.
ACCELERATION	MAX 10G.
AMPLITUDE	1.65mm ^{PP} CONSTANT.
DIRECTION	X, Y, Z.
DURATION	1 hr. for each direction.

TEST POINT :

1. Output voltage (APPLY some shock when checkins the o/p voltage, and observe any abnormalities.)
2. Ripple voltage (At nominal output and AC100V)
3. Mechanical Condition (No breakage)

認. APPD	<i>Haller</i> 11-JUN-92	設計 ENGR	R.C.Gan 11-May-92	圖面番号 DWG-No.	
検 図 C H K	K T N G 2-MAY-92	製 図 DWG	<i>Jubilee</i> 13-4-92	PA768-64-01	-

TEST RESULTS :
(after vibration)

TEST POINT	OUTPUT VOLTAGE (V)			RIPPLE VOLTAGE (mV)			MECHANICAL CONDITION	NOTE
	CH1	CH2	CH3	CH1	CH2	CH3		
BEFORE TEST	11.89	—	—	83.5	—	—	O. K	
X	11.90	—	—	83.5	—	—	O. K	
Y	11.90	—	—	83.5	—	—	O. K	
Z	11.90	—	—	83.0	—	—	O. K	

EVALUATION RESULT :



/ FAIL

VISUAL INSPECTION RESULT :

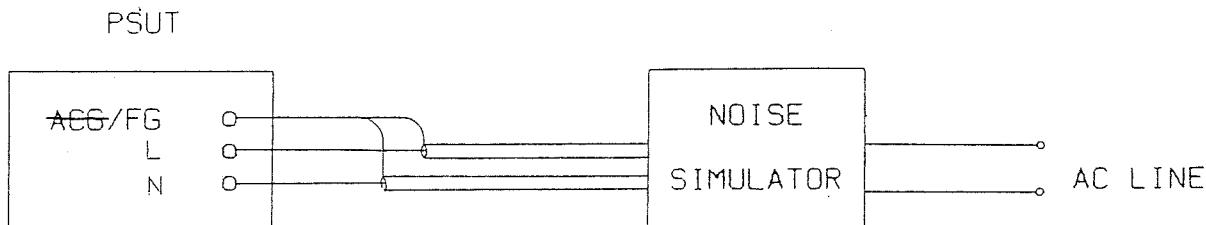


/ FAIL

認 APPD	.	設計 ENGR	.	図面番号 DWG-No.
検 査 圖 CHK	.	製 図 DWG	<i>July 1992</i>	PA768-64-02

NOISE SIMULATION TEST

Circuit for measurement and equipment used :



MODEL : ENS-24X (SANKI)

Testing Conditions :

Input Voltage : AC100V

Output Voltage : Rated

Output Current : 0% , 100%

Ambient Temp. : 25 °C

Settings :

MODE Normal , Common

TRIG SELECT Line or Ext (Line)

PULSE WIDTH 50, 200, 800, 1000ns

PHASE SHIFT 0 ~ 360 Degree

POLARITY + , -

NOISE LEVEL 0 ~ 2KV

Acceptance Criteria :

- 1) No damage of PSUT
- 2) No output failure
(eg. Over/Uundershoot ≤ 3% of Vo)
- 3) Check any abnormalities (eg. noise)

Evaluation Result :

PASS

/ FAIL

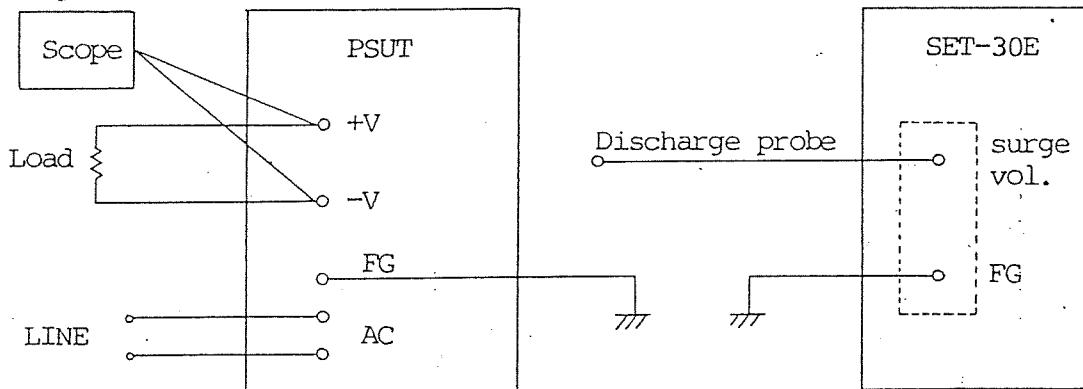
認 APPD	Haller 11.JUN.92	設 計 ENGR	S Y U M	図面番号 D WG-No.	PA768-61-01	
			20 . 4 . 92			
檢 図 C H K	K7 NG 20 . APR . 92	製 図 D WG	Zekken 13 . 4 . 92			

ELECTROSTATIC DISCHARGE TEST

EQUIPMENT : SET-30E (SANKI ELECTRONIC)

Discharge Resistor : 250 ohm
Capacitor unit : 200 pFCONDITIONS : Ambient Temperature : 25°C
Input Voltage : AC100V
Output Voltage : Rated
Output Current : Rated
Applied Voltage : ±3kV, ±5kV, ±10kV, ±15kVPROCEDURE :
The PSUT should be in a good working condition.
Discharge the applied voltage to the touchable parts of the PSUT (Chassis, Input Terminal, Output Terminal, FG Terminal, ACG Terminal) and check any abnormalities.

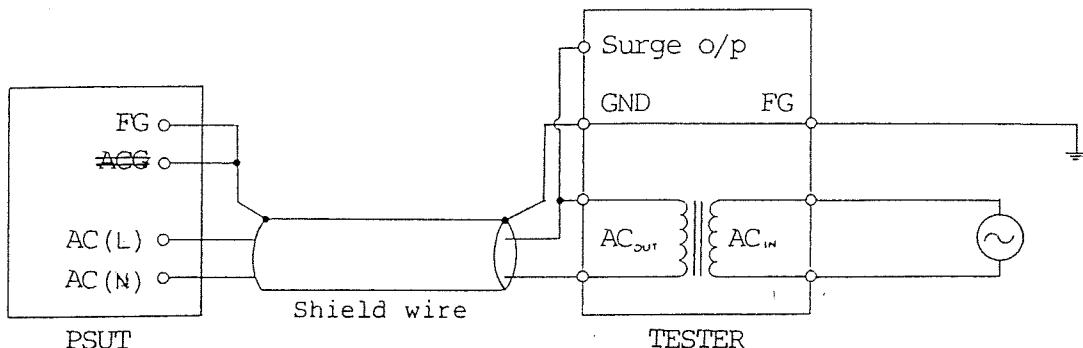
Each point to be tested 3 times with different polarity. Voltage should be applied from 3kV to 15kV.

ACCEPTANCE CRITERIA :
 1. No damage of PSUT
 2. No output failure ($\Delta V_o < 3\% \text{ of } V_o$)
 3. No abnormalitiesEVALUATION RESULT : PASS / FAIL

認 APPD	<i>Hattori</i> 11 · JUN · 92	設 計 ENGR	P.S. Gao 2 · May · 92	図面番号 D WG-No.
検 図 C H K	<i>L C T NG</i> 2 · May · 92	製 図 D W G	<i>Zhuo</i> 14 · 4 · 92	PA768-62-01

LIGHTNING SURGE TEST

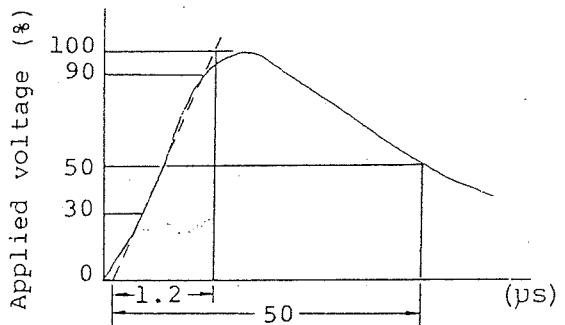
TEST CIRCUIT, TEST EQUIPMENT



CONDITIONS :

Input Voltage	:	AC100V
Output Voltage	:	Rated
Output Current	:	Rated
Applied Voltage	:	From 3kV in steps of 0.5kV Check the max. withstand voltage
Applied Point	:	Between FG - AC
Number of Test	:	Each voltage 3 times
Polarity	:	+ , -
Ambient Temp.	:	25°C

APPLIED VOLTAGE WAVEFORM :



ACCEPTANCE CRITERIA :

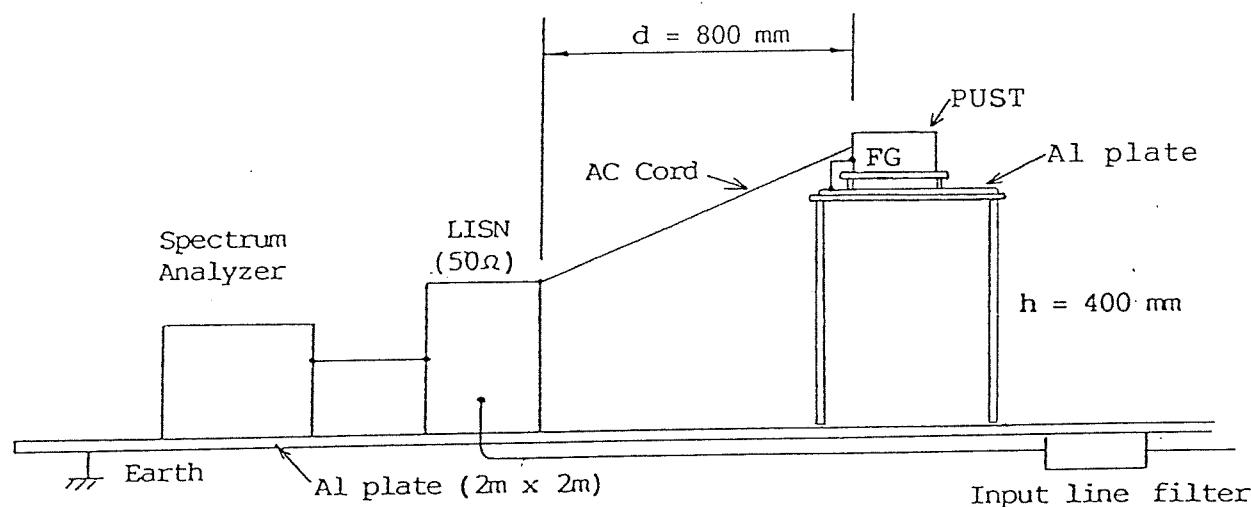
1. No damage to the PSUT
2. No output failure
3. No abnormalities

EVALUATION RESULT : 6.0 KV PASS / FAIL

認 APPD	<i>Hattori</i> 11 · JUN · 92	設 計 ENGR	P.S. Chan 2 · May · 92	図面番号 D WG - No.
検 図 C H K	K TNG 2 · MAY · 92	製 図 D WG	<i>Jackson</i> 13 · 4 · 92	PA768-74-01

E M I T E S T

TEST CIRCUIT :



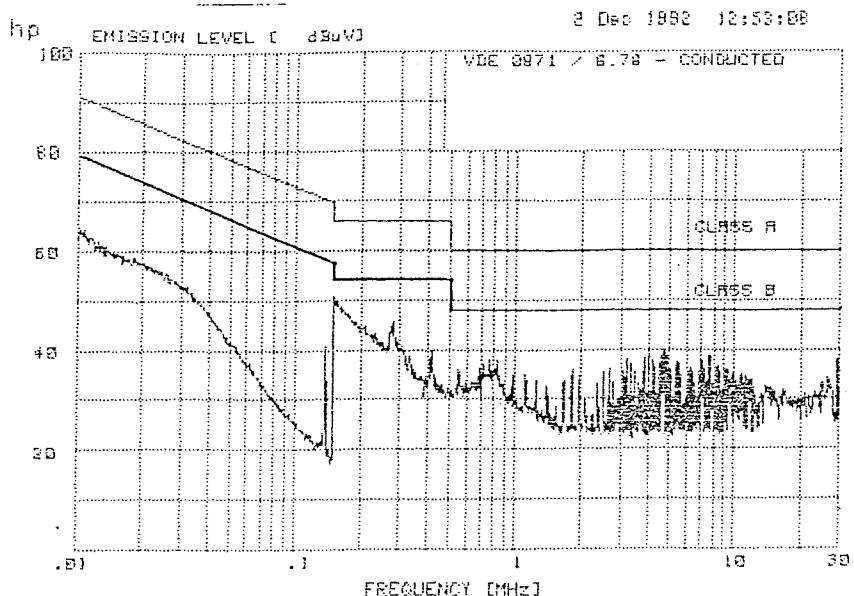
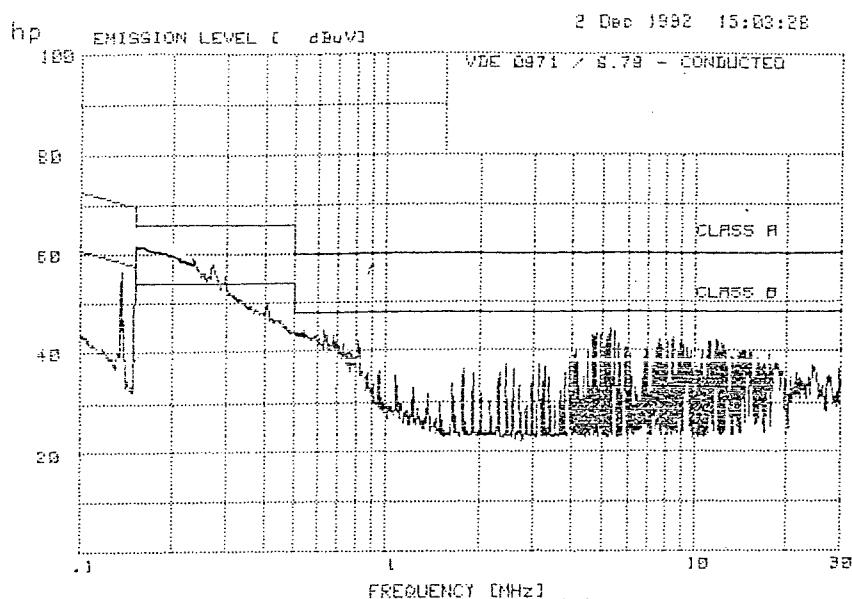
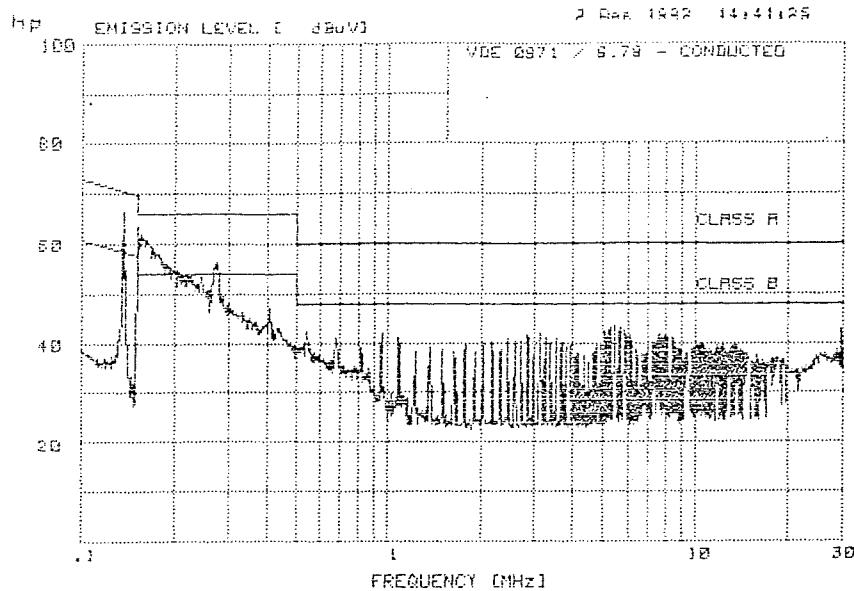
TEST EQUIPMENTS :

SPECTRUM ANALYZER	8568B	HEWLETT PACKARD
QUASI-PEAK ADAPTER	85650A	HEWLETT PACKARD
RF PRESELECTOR	85685A	HEWLETT PACKARD
LISN	3825/2	EMCO

CONDITIONS :

INPUT VOLTAGE	: AC100V, AC200V
OUTPUT VOLTAGE	: RATED
OUTPUT CURRENT	: RATED
AMBIENT TEMP.	: 25°C

認 APPD		設 ENGR		図面番号 DWG-No. PA768-71-02-	□
検 CHK		製 DWG			

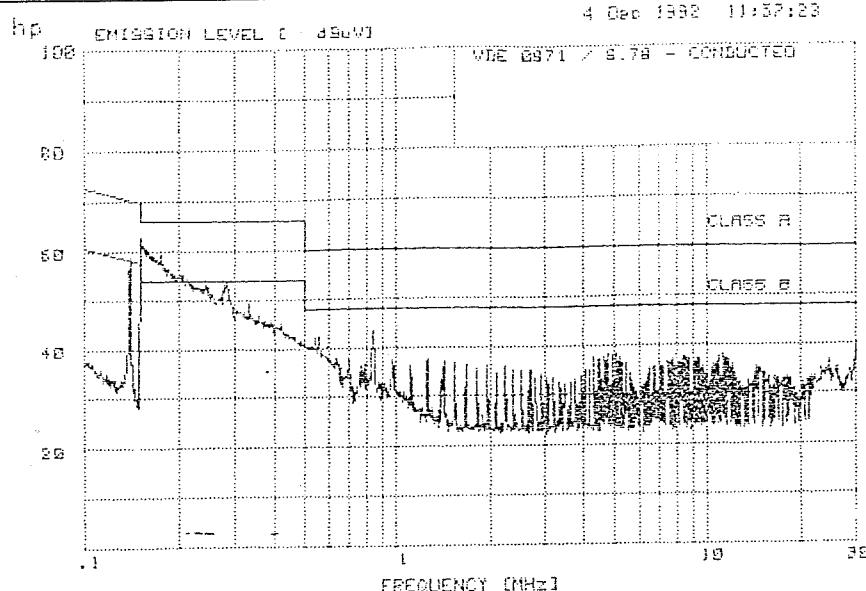


V D E
 With external cap.
 $0.33\mu\text{F}$ between
 Ac(L) and Ac(N).

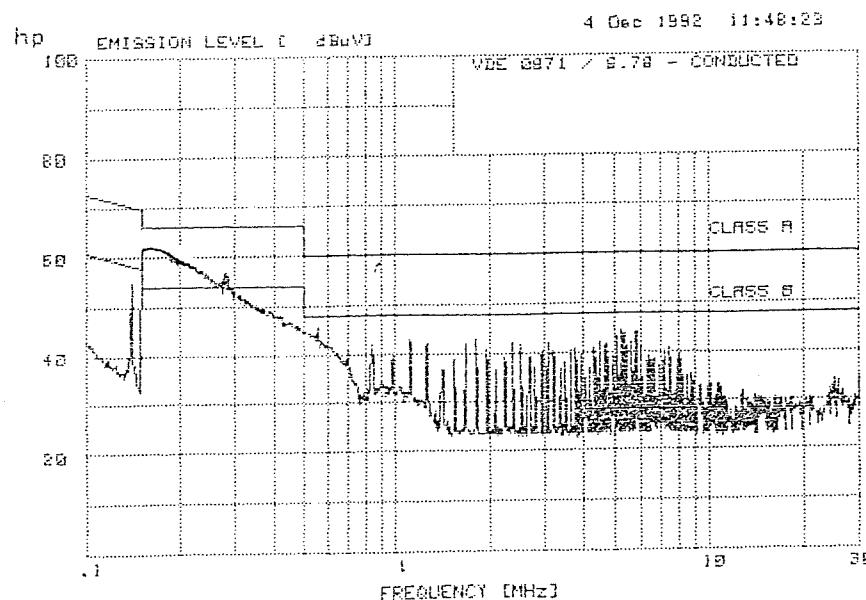
認 APPD	.	設 計 ENGR	.	図面番号 DWG-No.
検 CHK	.	製 図 DWG	.	
	.		.	
	.		.	

PA768-71-03 -

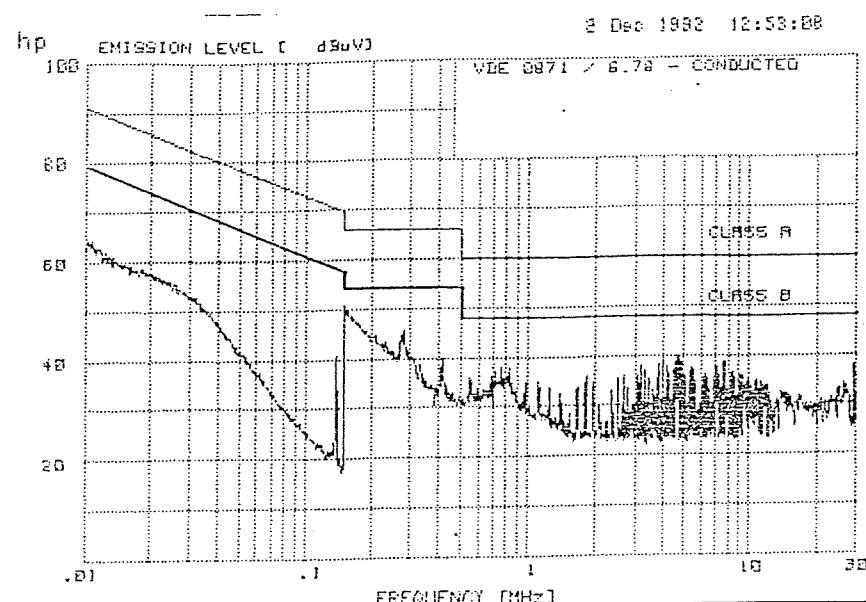




Vin = 100Vac



Vin = 200Vac

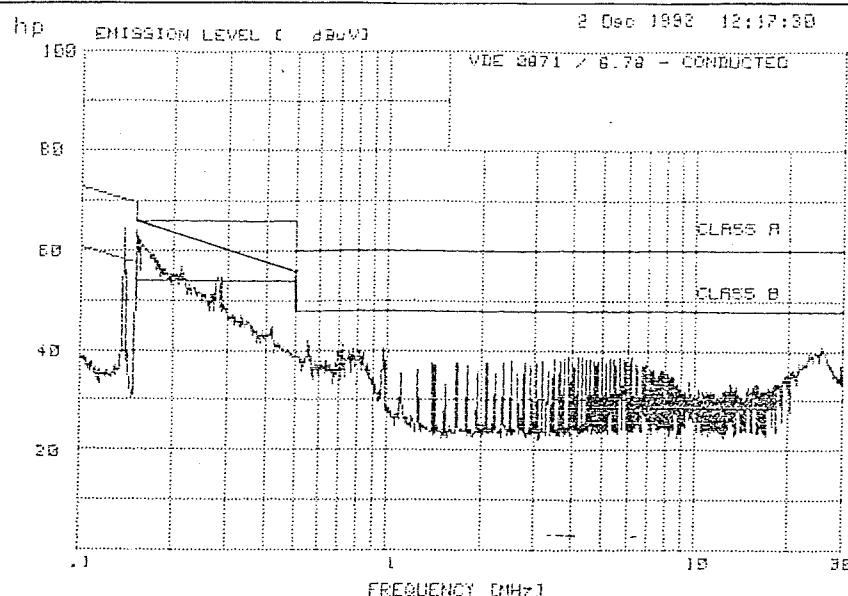


Vin = 200Vac

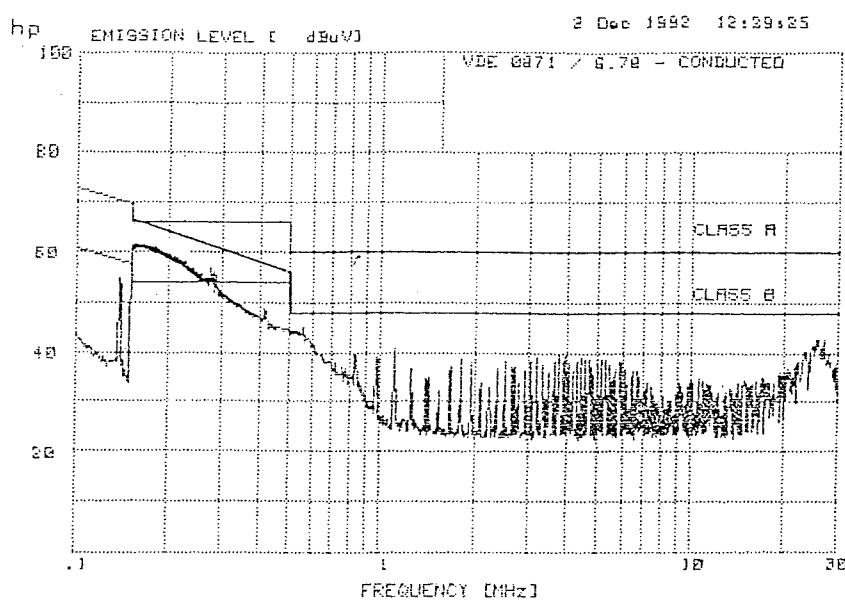
V D E

With external cap.
0.33μF between
Ac(L) and Ac(N).

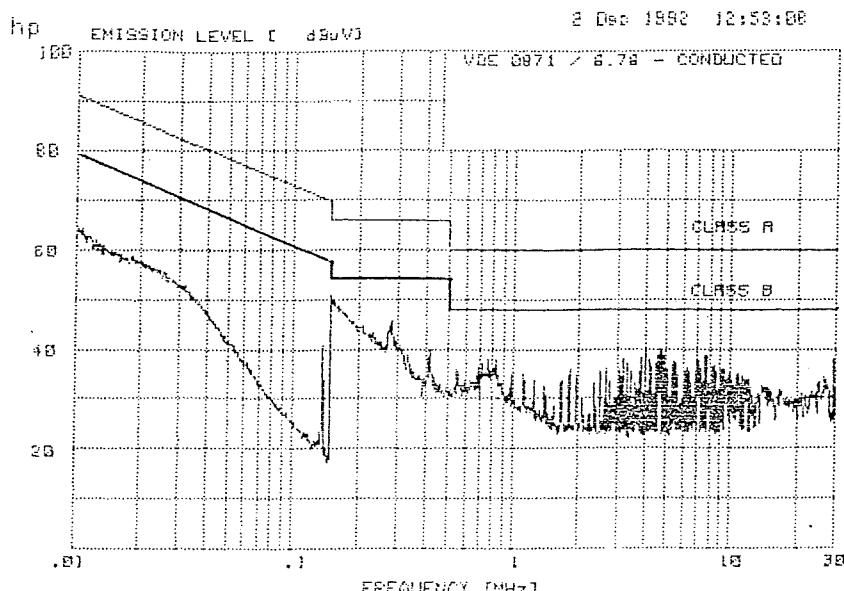
認 APPD	.	設計 ENGR	.	図面番号 D WG-No.
検 CHK	.	製 D WG	.	PA768-71-04 -



Vin = 100Vac



Vin = 200Vac



Vin = 200Vac

-V D E
With external
cap. 0.33μF
between Ac(L)
and Ac(N).

認 APPD	.	設 計 ENGR	.	図面番号 DWG-No.
検 図 C H K	.	製 図 DWG	.	PA768-71-05 -